

1 Setup

This chapter presents the experimental setup for electroluminescence (EL) measurements. Successful EL measurements consist of charge injection, charge recombination and luminescence detection. Therefore section 1.1 explains the general setup. The following section 1.2 explains the Perovskite Cell layout and electrical contacting of the cells. The emitted radiation is detected by a camera with the use of additional optics, explained in section 1.3. The chapter concludes with the consideration of noise and errors.

1.1 General Setup

The setup is enclosed in a black housing, shielding the inside from outside light and noise (see Figure 1.1). All parts inside the chamber are painted black to minimize internal reflections and thereby the detection of stray light. A vacuum pump, voltage source, multimeter and operating table with a computer are connected to the setup on the outside, providing further utility. Inside the enclosure are the probe holder and camera (footnote - PCO sensicam). To position the camera according to the sample size and used optics, the camera can be moved in three dimensions.

1.2 Electrical Connection

Perovskite Solar Cells (PSCs) are manufactured on 25 mm x 25 mm glass substrates (see Figure 1.2). Four cells are processed on one substrate, each single cell having dimensions of 4 mm x 3.5 mm. The cell stack consists of a glass substrate, with a xyz nm thick layer of Indium Tin Oxide (short ITO) deposited on top. xyz nm of Spiro-TTB are used as a Hole Transport Layer (HTL), followed by 500 nm of methylammonium lead triiodide (short MAPI) as the absorbing layer. The top side of the MAPI are contacted with xyz nm of C60 and BCP, acting as the Electron Transport Layer (short ETL). In the end of the fabrication process, xyz nm Gold are deposited on top of the ITO and the C60/BCP. Thus a holder with two pins, one on each gold pad, is needed to successfully contact the PSC. The used holder uses four pins, two to source voltage and two pins are used to check the contact.

The holder is electrically connected to a voltage supply¹, in series with a 100 m Ω resistance, R, and two multimeters² (see Figure 1.1). The multimeter measures the

¹Kikusuki

²Keithley 2000 Multimeter

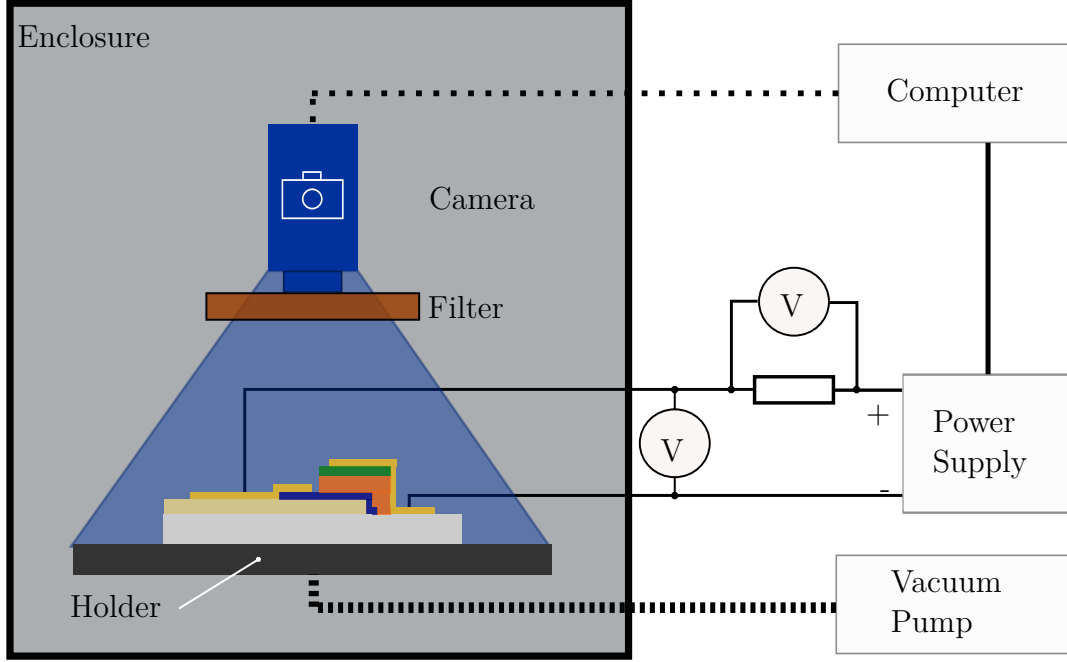


Figure 1.1: Schematic of the EL measurement setup. Camera and Probe are positioned inside the setup, and the computer, power supplies and measurement devices are provided from the outside.

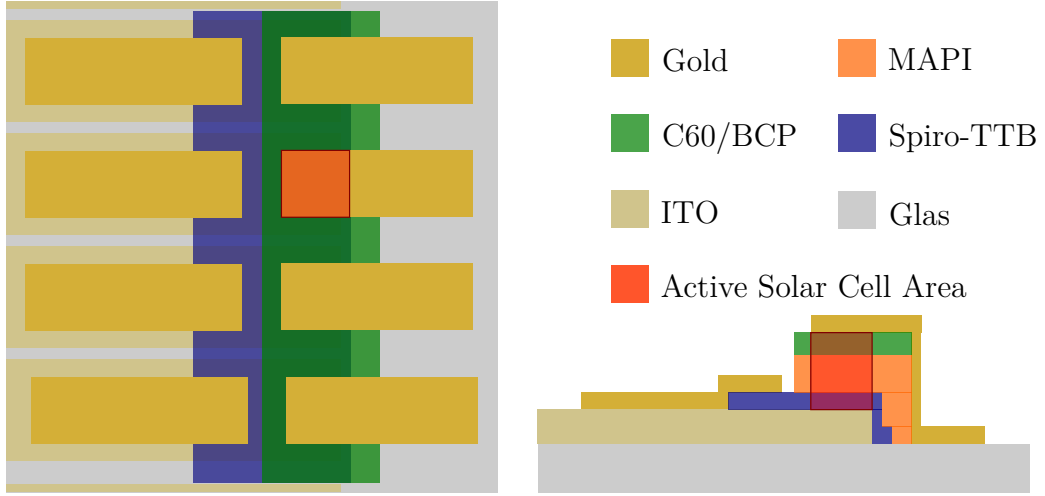


Figure 1.2: Schematic layout of the perovskite solar cell. Not to scale.

voltage drop across the PSC. The other multimeter measures the voltage drop across the resistor and the flowing current I is then calculated by Ohm's law:

$$I = \frac{U}{R}. \quad (1.1)$$

Structured wells and a vacuum flange in the holder fixate the PSC on the holder. This ensures mechanical and electrical contact stability throughout the measurement.

This setup enables safe contacting of the probes inside the enclosure. After correct poling, charges are injected and recombine. The emitted radiation is detected by a Camera, what requires the usage of filters and optics.

1.3 Luminescence detection

In the setup filters and optics are used to select and focus the emitted radiation at a specific distance onto the imaging sensor. This chapter explains the used components and physical processes.

1.3.1 Filters

Between probe and sensor a filter³ is used to filter the wavelengths reaching the detector. In filters absorption or interference are used to either transmit or reflect specific wavelengths. The filter in the setup is a bandpass filter and chosen accordingly to the luminescence emission spectrum of the PSC (see Figure 1.3). This reduces the detected wavelengths to 780 nm to 800 nm, the interval with maximal intensity of the PSC. This enables maximum sensitivity to the emitted radiation and limits the detection of stray light.

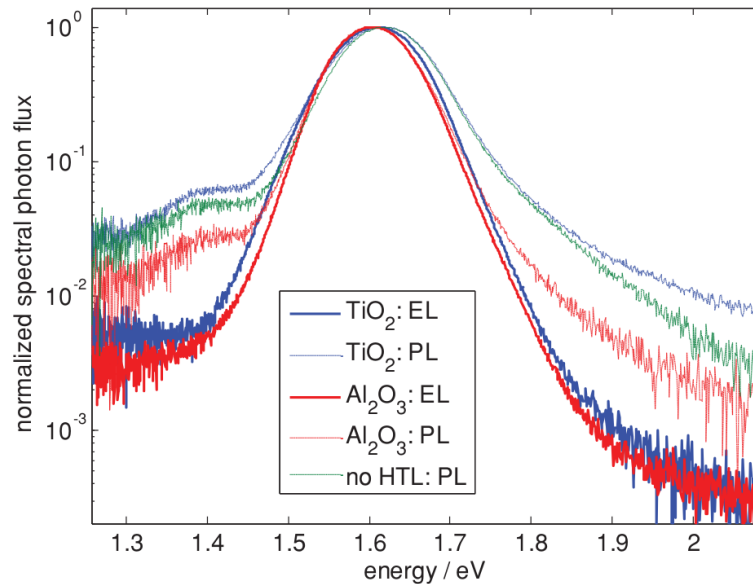


Figure 1.3: Emitted luminescence spectrum of the perovskite and transmission function of the filter. Taken from 2015 Predicting Voc. DIESES BILD DURCH PL MESSUNG VON MARVIN ERSETZEN ODER SO AUS INSTITUT!

³bk-Interferenzoptik, custom made product

1.3.2 Optics

Optics focus the radiation onto a charge coupled sensor (CCD). This setup uses a lens⁴ with a focus length of 25 mm and an aperature of 1.4, as listed by the manufacturer. The lens is positioned at the minimal object distance of 25 cm away from the PSC and mounted directly to the camera with a C-mount.

SKETCH FOR LENS SYSTEM

1.3.3 Charge Coupled Detectors

The radiation is focused onto a charge coupled detector (CCD) sensor⁵ in a camera⁶. CCD sensors are silicon chips structured into small squares, called wells (see Figure 1.4).^[3] The number of wells correspond to the number of pixel in the taken picture. Radiation generates charges, electrons and holes, and externally applied voltages separete and trap the charges in the wells. For a specific time, called exposure time, radiation hits the sensor and charges accumulate in the wells. The amount of generated electrons per incoming photon is called the quantum efficiency (QE), and depends on the sensor material and energy of the photon. The QE for the chosen sensor peaks at 500 nm and decays for larger wavelengths (compare Figure 1.5). For the wavelengths transmitted by the filter (see section before), the QE deeps to about 10 %, which reduces the sensitivity. After the exposure time a series of voltages is applied to shift the charges from the light sensitive wells to opaque covered wells. Then the charges are extracted row by row and the voltage of each well is measured. An A/D converter convertes the voltage into an Digital signal, which is saved and later processed.

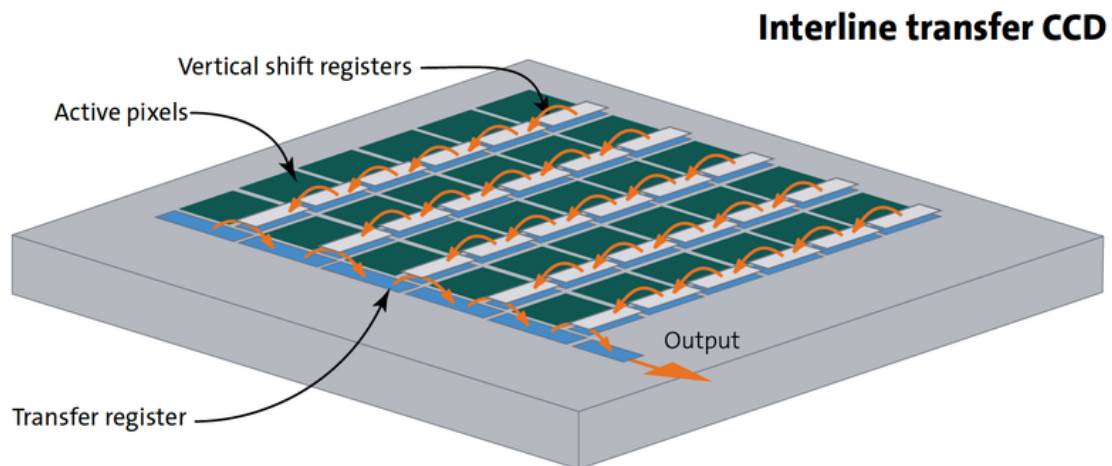


Figure 1.4: Schematic represantation of a CCD sensor. Taken from ^[2].

⁴Pentax, C2514-M (KP)

⁵Sony ICX285-AL

⁶PCO, sensicam qe

This process measures the EL distribution over the PSC surface. However several sources of errors occur, which are checked further.

1.4 Noise and measurement errors

Several sources of errors deviate the measured signal from the physical value and occur in the readout process of the CCD sensor. These correspond to dark noise, readout noise and hot or cold pixel. Dark noise refers to the thermal generation of electrons, depending on the temperature and the material's properties. To reduce thermal generation the CCD sensor is cooled to -12°C . Images without illumination or applied voltage are taken, and subtracted from the EL image, to further reduce dark noise.

Other sources of errors happen when the electrons are shifted from well to well, called readout noise. The manufacturer specifies the read out noise to be 5 electrons. This relates to about one count, with an analog to digital conversion efficiency of 4 electrons per count.^[1]

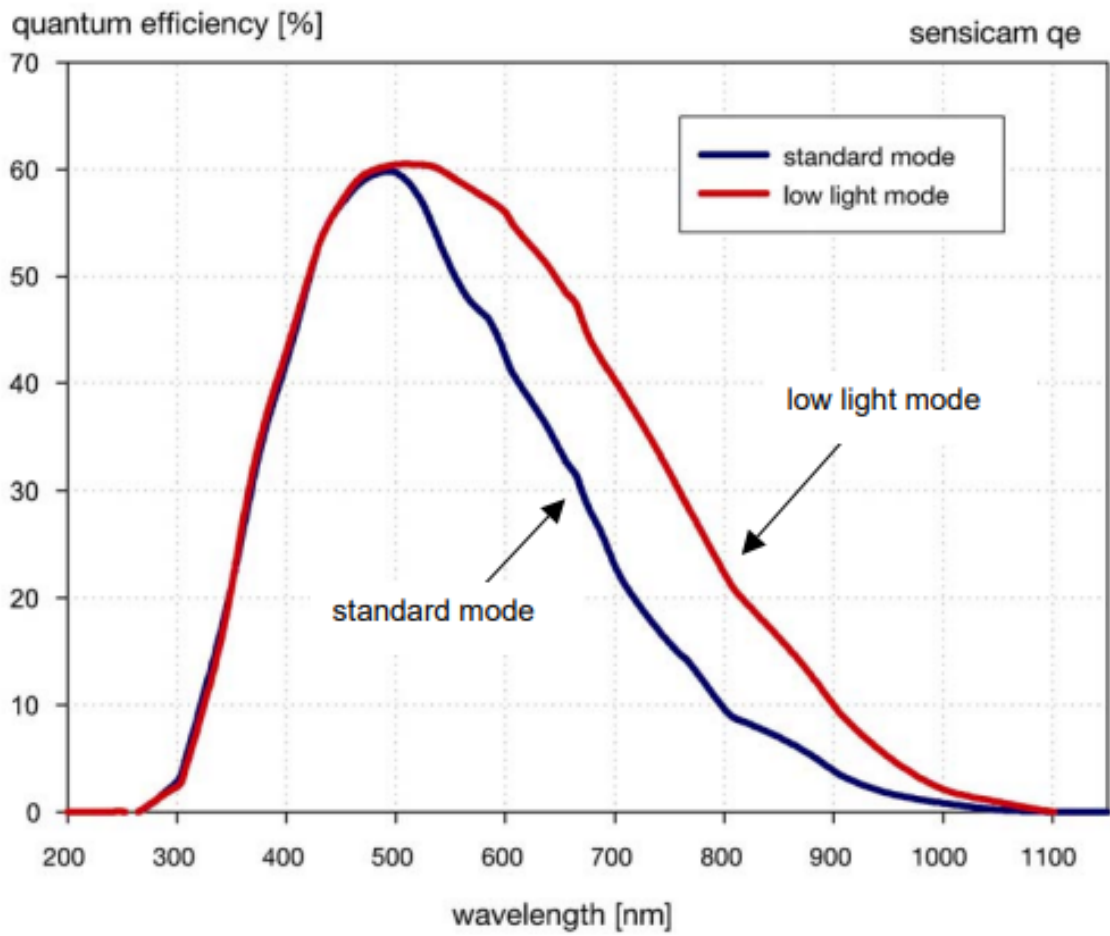


Figure 1.5: Quantum efficiency of the PCO sensicam qe, given by the manufacturer.

Bibliography

- [1] pco imaging. *Sensicam Operating Instructions*. 2004.
- [2] Stemmer Imaging. *CCD sensor types*. URL: <https://www.stemmer-imaging.com/en/knowledge-base/ccd/>.
- [3] Gerhard Schnell. *Sensoren in der Automatisierungstechnik*. Vieweg Verlag, 1993.